

Notice of References Cited	Application/Control No. 10/734,249	Applicant(s)/Patent Under Reexamination IWAHASHI ET AL.	
	Examiner Vu A. Le	Art Unit 2824	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-6,101,579	08-2000	Randolph et al.	711/131
X	B	US-6,091,627	07-2000	Luo et al.	365/154
X	C	US-6,078,544	06-2000	Park, Yeon Jun	365/230.05
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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